

November 2013

FQD7P20

P-Channel QFET® MOSFET

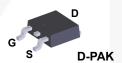
-200 V, -5.7 A, 690 mΩ

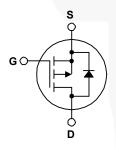
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance • Low Crss (Typ. 25 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, • 100% Avalanche Tested DC motor control, and variable switching power applications.

Features

- -5.7 A, -200 V, $R_{DS(on)}$ = 690 m Ω (Max.) @ V_{GS} = -10 V, $I_D = -2.85 A$
- Low Gate Charge (Typ. 19 nC)





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQD7P20TM	Unit
V _{DSS}	Drain-Source Voltage		-200	V
I _D	Drain Current - Continuous (T _C = 25°C)		-5.7	Α
	- Continuous (T _C = 100°C)		-3.6	Α
I _{DM}	Drain Current - Pulsed (N	lote 1)	-22.8	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2		570	mJ
I _{AR}	Avalanche Current (N	Note 1)	-5.7	Α
E _{AR}	Repetitive Avalanche Energy (N	Note 1)	5.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C)		55	W
	- Derate above 25°C		0.44	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds.		300	°C

Thermal Characteristics

Symbol	Parameter	FQD7P20TM	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	50	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQD7P20TM	FQD7P20	D-PAK	Tape and Reel	330 mm	16 mm	2500 units

Flectrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Uni
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = -250 μA	-200			V
ΔBV _{DSS} / ΔT	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		-0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -200 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -160 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -30 V, V _{DS} = 0 V		-	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V		I	100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -2.85 A		0.54	0.69	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -40 V, I _D = -2.85 A		3.7		S
Dynam	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$		590	770	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		140	180	pF
C _{rss}	Reverse Transfer Capacitance			25	35	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = -100 V, I _D = -7.3 A,		15	40	ns
t _r	Turn-On Rise Time	$R_{G} = 25 \Omega$		110	230	ns
t _{d(off)}	Turn-Off Delay Time	11.6 - 20.32		30	70	ns
t _f	Turn-Off Fall Time	(Note 4)		42	90	ns
Q _g	Total Gate Charge	V _{DS} = -160 V, I _D = -7.3 A,		19	25	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		4.6		nC
Q _{gd}	Gate-Drain Charge	(Note 4)	/	9.5		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Did				-5.7	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				-22.8	Α
V _{SD}	Drain-Source Diode Forward Voltage V _{GS} = 0 V, I _S = -5.7 A			-	-5.0	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = -7.3 A,		180		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs		1.07	//	μC

- Notes. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 26.3 mH, I_{AS} = -5.7 A, V_{DD} = -50 V, R_{G} = 25 Ω , starting T_{J} = 25°C. 3. $I_{SD} \le$ -7.3 A, di/dt \le 300 A/µs, $V_{DD} \le$ BV_{DSS}, starting T_{J} = 25°C. 4. Essentially independent of operating temperature.

Typical Characteristics

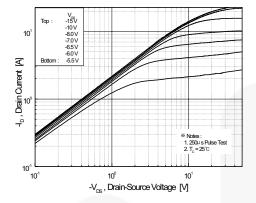


Figure 1. On-Region Characteristics

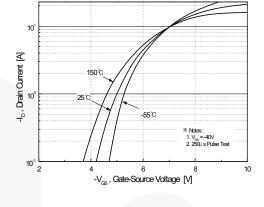


Figure 2. Transfer Characteristics

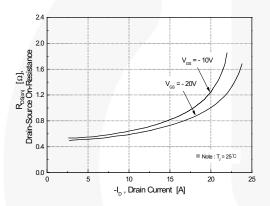


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

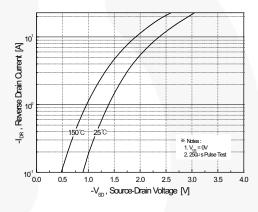


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

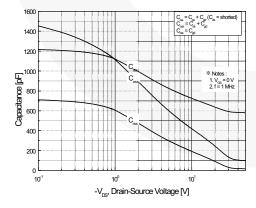


Figure 5. Capacitance Characteristics

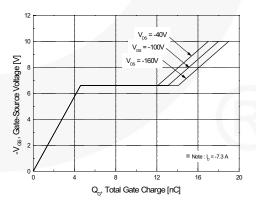


Figure 6. Gate Charge Characteristics

Dain-Source Beagachon Vollage * Notes: 1.V_a=0.V 2. l_a=250 I A

Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

T,, Junction Temperature [°C]

150

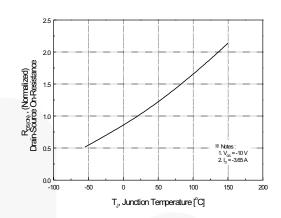


Figure 8. On-Resistance Variation vs. Temperature

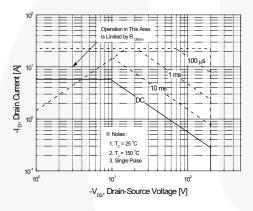


Figure 9. Maximum Safe Operating Area

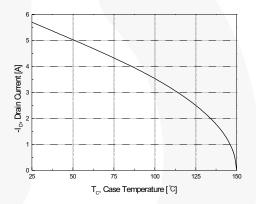


Figure 10. Maximum Drain Current vs. Case Temperature

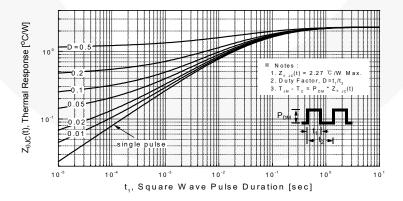


Figure 11. Transient Thermal Response Curve

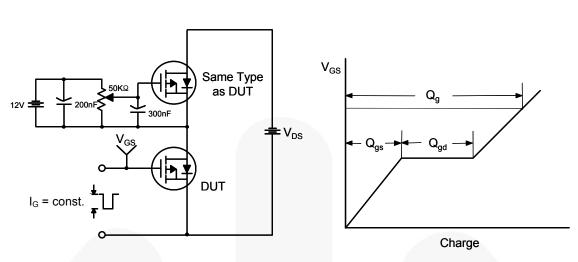


Figure 12. Gate Charge Test Circuit & Waveform

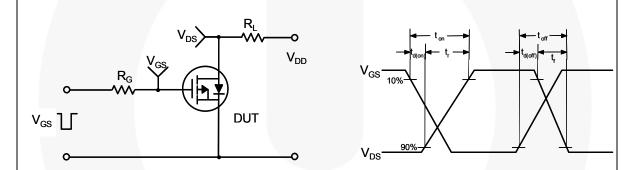


Figure 13. Resistive Switching Test Circuit & Waveforms

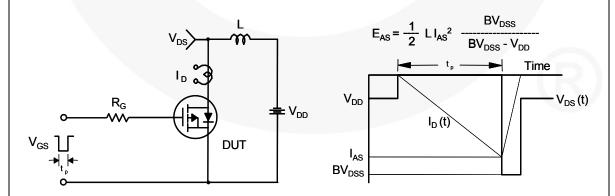
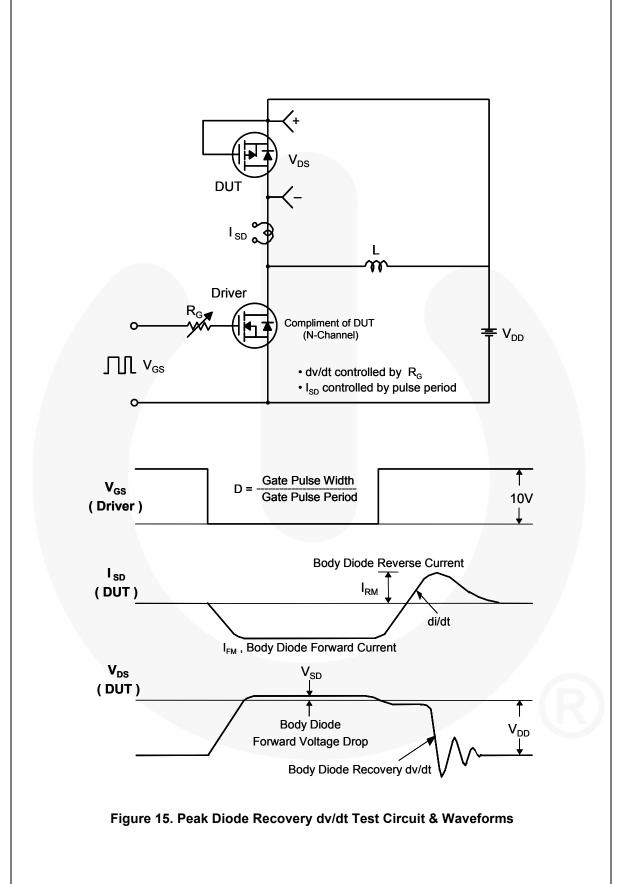


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

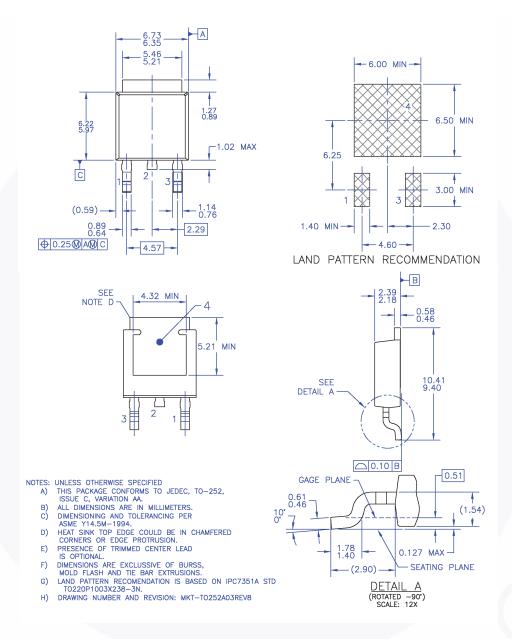


Figure 16. TO252 (D-PAK), Molded, 3-Lead, Option AA&AB

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